

FCC PART 15C TEST REPORT No.**I18Z60848-IOT02**

for

Shenzhen Tinno Mobile Technology Corp.

smart phone

Model Name: C210AE

FCC ID:2AM86WC210

with

Hardware Version: V0.3

Software Version:C210AE-V02

Issued Date: 2018-6-25



Note:

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REPORT HISTORY

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1. Test Laboratory

1.1. TestingLocation

Conducted testing Location: CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,

P. R. China100191

Radiated testing Location: CTTL(Shouxiang)

Address: No. 51 Shouxiang Science Building, Xueyuan Road,

Haidian District, Beijing, P. R. China100191

1.2. TestingEnvironment

Normal Temperature: $15-35^{\circ}$ C Relative Humidity: 20-75%

1.3. Project data

Testing Start Date: 2018-5-23 Testing End Date: 2018-6-25

1.4. Signature

Wu Le

(Prepared this test report)

Sun Zhenyu

(Reviewed this test report)

Lv Songdong

(Approved this test report)



2. ClientInformation

2.1. Applicant Information

Company Name: Wiko SAS

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Postal Code: /
Country: /

Telephone: 33488089515 Fax: 33488089520

2.2. Manufacturer Information

Company Name: Shenzhen Tinno Mobile Technology Corp.

Address/Post: 4/F, H-3 Building, OCT Eastern industrial Park, No.1 XiangShan East

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City: /
Postal Code: /
Country: /

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3. Equipment UnderTest (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description smart phone
Model Name C210AE

FCC ID 2AM86WC210

Frequency Band ISM 2400MHz~2483.5MHz Type of Modulation GFSK/π/4 DQPSK/8DPSK

Number of Channels 79

Power Supply 3.8VDC by Battery

3.2. Internal Identification of EUT

	EUT ID*	SN or IMEI	HW Version	SW Version
	EUT2	357960090021951	V0.3	C210AE-V02
	EUT3	357960090005848	V0.3	C210AE-V02
*	ELIT ID. ic	used to identify the to	ct cample in the	lab internally

^{*}EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE

AE ID*	Description			
AE1	Battery	/	inbuilt	
AE2	Charger	/	1860848CH002	
AE3	USB Cable	/	1860848DC002	
AE1				
Model		C210AEBATT		
Manufac	turer	Ningbo Veken Battery Co.	, Ltd	
Capacita	nce	2500mAh		
Nominal	voltage	3.8V		
AE2				
Model		TN-050100U4A		
Manufac	turer	Shenzhen BMT Electronic	s Co.,Ltd	
Length of cable		/		
AE3				
Model		/		

^{*}AE ID: is used to identify the test sample in the lab internally.

3.4. EUT set-ups

Manufacturer Length of cable

EUT set-up No.	Combination of EUT and AE	Remarks
Set.10	EUT2+ AE1+ AE2+ AE3	BT



3.5. Normal Accessory setting

Fully charged battery should be used during the test.

3.6. General Description

The Equipment Under Test (EUT) is a model of smart phonewith integrated antenna. It consists of normal options: lithium battery, charger. Manual and specifications of the EUT were provided to fulfill the test. Samples undergoing test were selected by the Client.



4. Reference Documents

4.1. Documents supplied by applicant

EUT feature information is supplied by the applicant or manufacturer, which is the basis of testing.

4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
	FCC CFR 47, Part 15, Subpart C:	
	15.205 Restricted bands of operation;	
FCC Part15	15.209 Radiated emission limits, general requirements;	2016
	15.247 Operation within the bands 902–928MHz,	
	2400-2483.5 MHz, and 5725-5850 MHz.	
ANCI C62 10	American National Standard of Procedures for	luna 2012
ANSI C63.10	Compliance Testing of Unlicensed Wireless Devices	June,2013



5. Test Results

5.1. Summary of Test Results

Abbreviations used in this clause:

- **P** Pass, The EUT complies with the essential requirements in the standard.
- F Fail, The EUT does not comply with the essential requirements in the standard
- NA Not Applicable, The test was not applicable
- NP Not Performed, The test was not performed by CTTL

SUMMARY OF MEASUREMENT RESULTS	Sub-clause	Verdict
Peak Output Power - Conducted	15.247 (b)(1)	Р
Frequency Band Edges	15.247 (d)	Р
Transmitter Spurious Emission - Conducted	15.247 (d)	Р
Transmitter Spurious Emission - Radiated	15.247, 15.205, 15.209	Р
Time of Occupancy (Dwell Time)	15.247 (a) (1)(iii)	Р
20dB Bandwidth	15.247 (a)(1)	NA
Carrier Frequency Separation	15.247 (a)(1)	Р
Number of hopping channels	15.247 (a)(b)(iii)	Р
AC Powerline Conducted Emission	15.107, 15.207	Р

Please refer to ANNEX A for detail.

The measurement is made according to ANSI C63.10.

5.2. Statements

CTTL has evaluated the test cases requested by the applicant /manufacturer as listed in section 5.1 of this report for the EUT specified in section 3 according to the standards or reference documents listed in section 4.2



6. Test Facilities Utilized

Conducted test system

No.	Equipment	Model	Serial	Manufacturer	Calibration	Calibration
NO.	Equipment	wodei	Number	Manufacturer	Period	Due date
1	Vector Signal	FSQ26	200136	Rohde &	1 voor	2018-09-30
!	Analyzer	F3Q26	200136	Schwarz	1 year	2016-09-30
2	Test Receiver	ESCI 3	100344	Rohde &	1 voor	2019-02-28
	rest Receiver	E3CI 3	100344	Schwarz	1 year	2019-02-26
3	LISN	ENY216	101200	Rohde &	1 voor	2019-04-15
3	LION	ENTZIO	101200	Schwarz	1 year	2019-04-15
4	Shielding Room	S81	/	ETS-Lindgren	/	/
5	Pluotooth	CBT	101042	Rohde &	1 voor	2019-03-08
5	Bluetooth	CDI	101042	Schwarz	1 year	2019-03-06

Radiated emission test system

No.	Equipment	Model	Serial	Manufacturer	Calibration	Calibration
140.	Equipment	Wiodei	Number	Wandacturer	Period	Due date
1	Test Receiver	ESU26	100235	Rohde &	1 year	2019-03-01
ı	rest Receiver	E3020	100233	Schwarz	1 year	2019-03-01
2	BiLog Antenna	VULB9163	301	Schwarzbeck	3 years	2019-02-03
	Dual-Ridge					
3	Waveguide Horn	3116	2661	ETS-Lindgren	3 years	2020-07-27
	Antenna					
4	EMI Antenna	3115	6914	ETS-Lindgren	3 Years	2020-05-21
E	Pluotooth	CDT	101042	Rohde &	1 year	2010 02 09
5	Bluetooth	CBT 10	101042	Schwarz	1 year	2019-03-08



7. Measurement Uncertainty

7.1. Peak Output Power - Conducted

Measurement Uncertainty:

Measurement Uncertainty(k=2)	0.66dB
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7.2. Frequency Band Edges

Measurement Uncertainty:

7.3. Transmitter Spurious Emission - Conducted

Measurement Uncertainty:

FrequencyRange	Uncertainty(k=2)
30 MHz ~ 8 GHz	1.22dB
8 GHz ~ 12.75 GHz	1.51dB
12.7GHz ~ 26 GHz	1.51dB

7.4. Transmitter Spurious Emission - Radiated

Measurement Uncertainty:

FrequencyRange	Uncertainty(k=2)
<1 GHz	4.86dB
> 1 GHz	5.26dB

7.5. Time of Occupancy (Dwell Time)

Measurement Uncertainty:

Measurement Uncertainty(k=2)	0.88ms
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7.6. 20dB Bandwidth

Measurement Uncertainty:

Measurement Uncertainty(k=2) 61.936Hz



7.7. Carrier Frequency Separation

Measurement Uncertainty:

Measurement Uncertainty(k=2)	61.936Hz
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7.8. AC Powerline Conducted Emission

Measurement Uncertainty:

Measurement Uncertainty(k=2)	3.38dB
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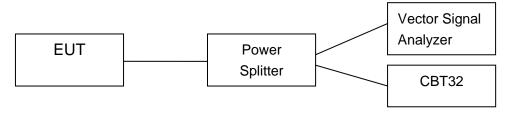
ANNEX A: Detailed Test Results

A.1. Measurement Method

A.1.1. Conducted Measurements

The measurement is made according to ANSI C63.10.

- 1). Connect the EUT to the test system correctly.
- 2). Set the EUT to the required work mode (Transmitter, receiver or transmitter & receiver).
- 3). Set the EUT to the required channel.
- 4). Set the EUT hopping mode (hopping or hopping off).
- 5). Set the spectrum analyzer to start measurement.
- 6). Record the values. Vector Signal Analyzer



A.1.2. Radiated Emission Measurements

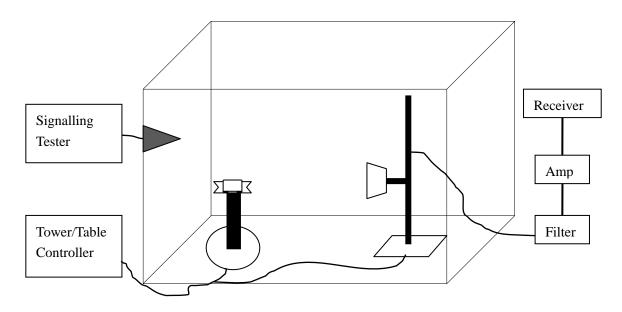
The measurement is made according to ANSI C63.10

The radiated emission test is performed in semi-anechoic chamber. The distance from the EUT to the reference point of measurement antenna is 3m. The test is carried out on both vertical and horizontal polarization and only maximization result of both polarizations is kept. During the test, the turntable is rotated 360° and the measurement antenna is moved from 1m to 4m to get the maximization result.

In the case of radiated emission, the used settings are as follows,

Sweep frequency from 30 MHz to 1GHz, RBW = 100 kHz, VBW = 300 kHz;

Sweep frequency from 1 GHz to 26GHz, RBW = 1MHz, VBW = 1MHz;





A.2. Peak Output Power - Conducted

Method of Measurement: See ANSI C63.10-clause 7.8.5

a) Use the following spectrum analyzer settings:

Span: 6MHzRBW: 3MHzVBW: 3MHz

Sweep time: 2.5msDetector function: peak

• Trace: max hold

b) Allow trace to stabilize.

c) Use the marker-to-peak function to set the marker to the peak of the emission.

d) The indicated level is the peak output power.

Measurement Limit:

Standard	Limit (dBm)
FCC Part 15.247(b)(1)	< 30

Measurement Results:

For GFSK

Channel	Ch 0 2402 MHz	Ch 39 2441 MHz	Ch 78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	5.57	6.72	5.21	Р

Forπ/4 DQPSK

Channel	Ch 0 2402 MHz	Ch 39 2441 MHz	Ch 78 2480 MHz	Conclusion
	2402 1011 12	2441 1011 12	2400 WII IZ	
Peak Conducted	4.84	5.71	4.33	P
Output Power (dBm)	7.04	5.71	4.55	'

For 8DPSK

Channel	Ch 0 2402 MHz	Ch 39 2441 MHz	Ch 78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	5.13	6.01	4.53	Р

Conclusion: PASS



A.3. Frequency Band Edges – Conducted

Method of Measurement: See ANSI C63.10-clause 7.8.6

Connect the spectrum analyzer to the EUT using an appropriate RF cable connected to the EUT output. Configure the spectrum analyzer settings as described below (be sure to enter all losses between the unlicensed wireless device output and the spectrum analyzer).

-Span: 10 MHz

Resolution Bandwidth: 100 kHzVideo Bandwidth: 300 kHz

Sweep Time:AutoDetector: PeakTrace: max hold

Place a marker at the end of the restricted band closest to the transmit frequency to show compliance. Also measure any emissions in the restricted bands. Save the spectrum analyzer plot. Repeat for each power and modulation for lowest and highest channel.

Observe the stored trace and measure the amplitude deltabetween the peak of the fundamental and the peak of the band-edge emission. This is not anabsolute field strength measurement; it is only a relative measurement to determine the amount bywhich the emission drops at the band edge relative to the highest fundamental emission level.

Measurement Limit:

Standard	Limit (dBc)
FCC 47 CFR Part 15.247 (d)	<-20

Measurement Result:

For GFSK

Channel	Hopping	Band Edge	Power (dBc)	Conclusion
0	Hopping OFF	Fig.1	-56.84	Р
0	Hopping ON	Fig.2	-62.73	Р
70	Hopping OFF	Fig.3	-65.17	Р
78	Hopping ON	Fig.4	-64.28	Р

Forπ/4 DQPSK

Channel	Hopping	Band Edge Power (dBc)		Conclusion
0	Hopping OFF	Fig.5	-57.53	Р
U	Hopping ON	Fig.6	-62.30	Р
78	Hopping OFF	Fig.7	-63.18	Р
	Hopping ON	Fig.8	-63.32	Р

For 8DPSK

Channel	Hopping	Band Edge Power (dBc)		Conclusion
0	Hopping OFF	Fig.9	-56.88	Р
U	Hopping ON	Fig.10	-58.31	Р



70	Hopping OFF	Fig.11	-61.50	Р
78	Hopping ON	Fig.12	-63.62	Р

Conclusion: PASS
Test graphs as below

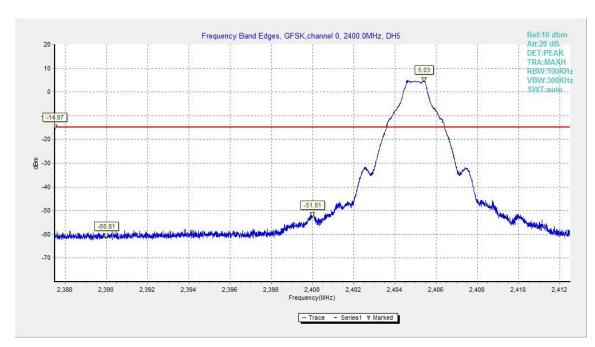


Fig.1. Frequency Band Edges: GFSK, Channel 0, Hopping Off

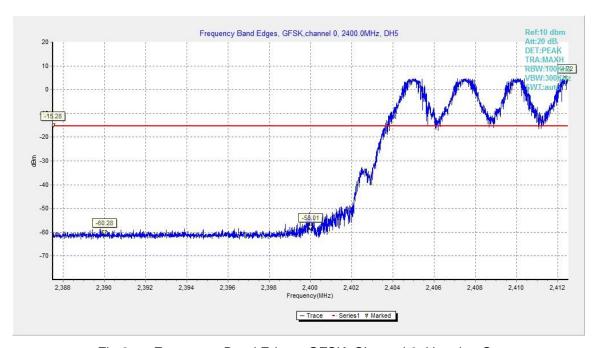


Fig.2. Frequency Band Edges: GFSK, Channel 0, Hopping On



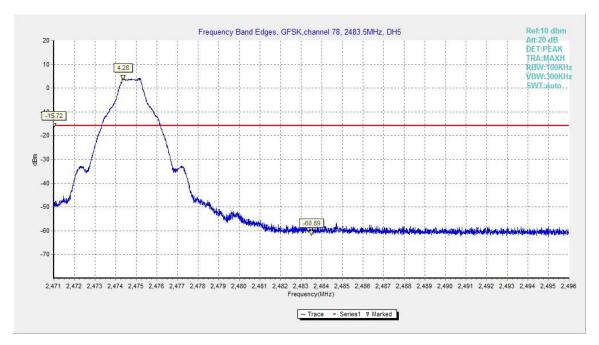


Fig.3. Frequency Band Edges: GFSK, Channel 78, Hopping Off

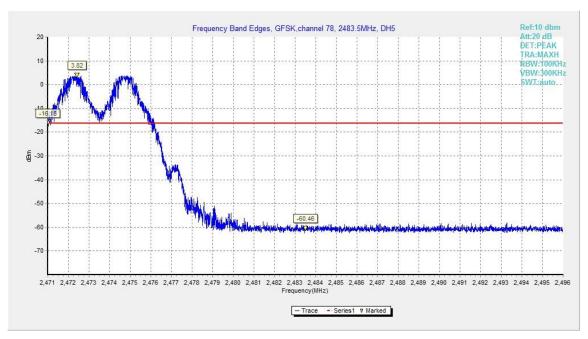


Fig.4. Frequency Band Edges: GFSK, Channel 78, Hopping On



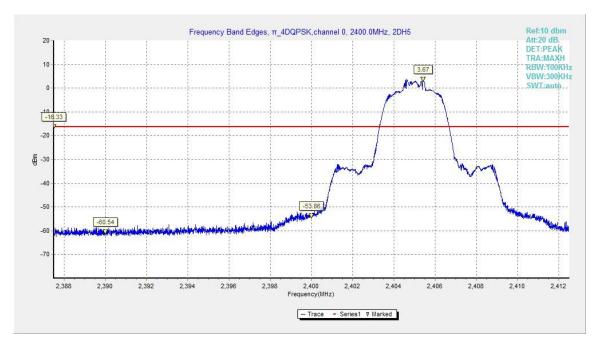


Fig.5. Frequency Band Edges: $\pi/4$ DQPSK, Channel 0, Hopping Off

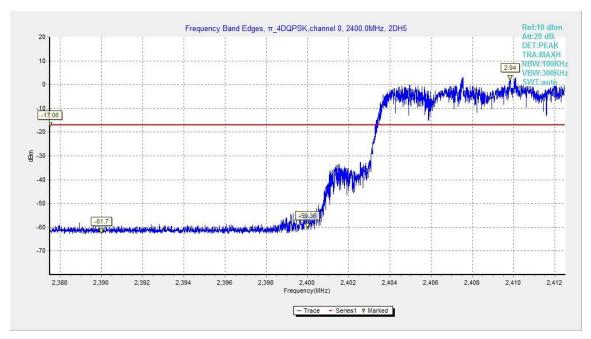


Fig.6. Frequency Band Edges: π/4 DQPSK, Channel 0, Hopping On



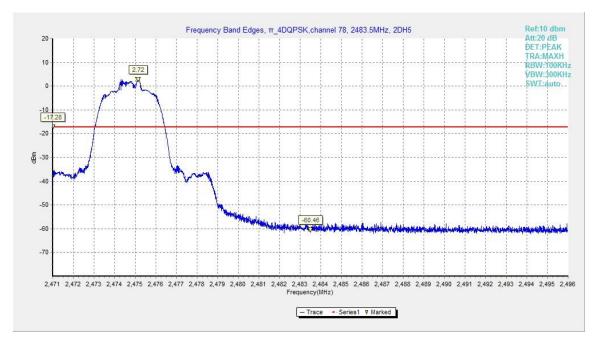


Fig.7. Frequency Band Edges: $\pi/4$ DQPSK, Channel 78, Hopping Off

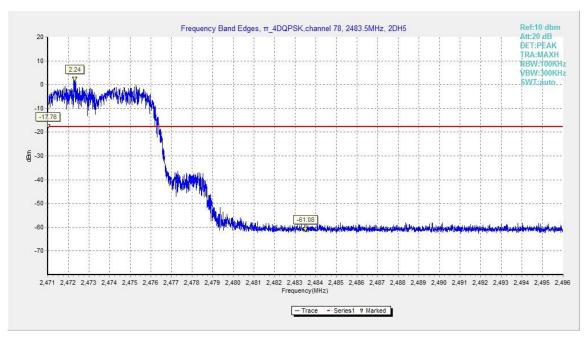


Fig.8. Frequency Band Edges: π/4 DQPSK, Channel 78, Hopping On



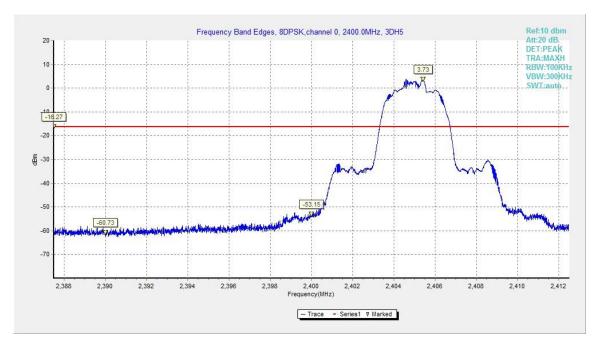


Fig.9. Frequency Band Edges: 8DPSK, Channel 0, Hopping Off

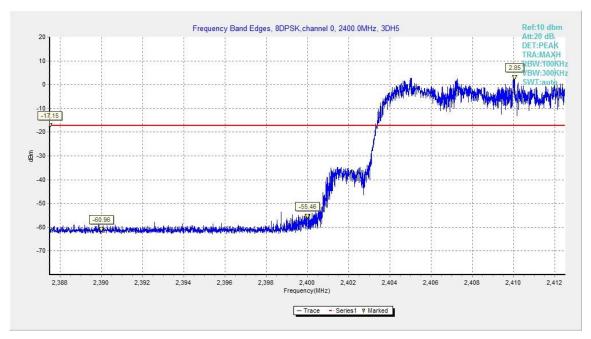


Fig.10. Frequency Band Edges: 8DPSK, Channel 0, Hopping On



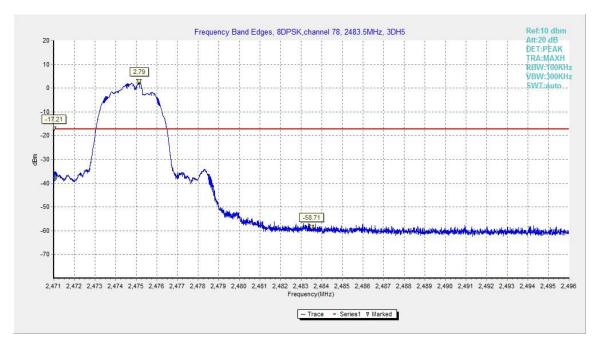


Fig.11. Frequency Band Edges: 8DPSK, Channel 78, Hopping Off

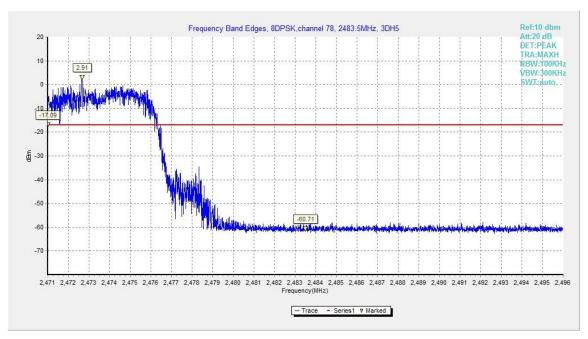


Fig.12. Frequency Band Edges: 8DPSK, Channel 78, Hopping On



A.4. Transmitter Spurious Emission - Conducted

Method of Measurement: See ANSI C63.10-clause 7.8.8

Measurement Procedure - Reference Level

- 1. Set the RBW = 100 kHz.
- 2. Set the VBW = 300 kHz.
- 3. Set the span to 5-30 % greater than the EBW.
- 4. Detector = peak.
- 5. Sweep time = auto couple.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.
- 8. Use the peak marker function to determine the maximum power level in any 100 kHz band segment within the fundamental EBW. Next, determine the power in 100 kHz band segments outside of the authorized frequency band using the following measurement:

Measurement Procedure - Unwanted Emissions

- 1. Set RBW = 100 kHz.
- 2. Set VBW = 300 kHz.
- 3. Set span to encompass the spectrum to be examined.
- 4. Detector = peak.
- 5. Trace Mode = max hold.
- 6. Sweep = auto couple.
- 7. Allow the trace to stabilize (this may take some time, depending on the extent of the span).

Ensure that the amplitude of all unwanted emissions outside of the authorized frequency band (excluding restricted frequency bands) is attenuated by at least the minimum requirements specified above.

Measurement Limit:

Standard	Limit	
ECC 47 CED Dort 15 247 (d)	20dB below peak output power in 100 kHz	
FCC 47 CFR Part 15.247 (d)	bandwidth	

Measurement Results:

For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch 0	Center Frequency	Fig.13	Р



2402 MHz	30 MHz ~ 1 GHz	Fig.14	Р
	1 GHz ~ 3 GHz	Fig.15	Р
	3 GHz ~ 10 GHz	Fig.16	Р
	10 GHz ~ 26 GHz	Fig.17	Р
	Center Frequency	Fig.18	Р
Ch 20	30 MHz ~ 1 GHz	Fig.19	Р
Ch 39 2441 MHz	1 GHz ~ 3 GHz	Fig.20	Р
	3 GHz ~ 10 GHz	Fig.21	Р
	10 GHz ~ 26 GHz	Fig.22	Р
Ch 78 2480 MHz	Center Frequency	Fig.23	Р
	30 MHz ~ 1 GHz	Fig.24	Р
	1 GHz ~ 3 GHz	Fig.25	Р
	3 GHz ~ 10 GHz	Fig.26	Р
	10 GHz ~ 26 GHz	Fig.27	Р

For π/4 DQPSK

Channel	Frequency Range	Test Results	Conclusion
	Center Frequency	Fig.28	Р
Ch O	30 MHz ~ 1 GHz	Fig.29	Р
Ch 0 2402 MHz	1 GHz ~ 3 GHz	Fig.30	Р
2 102 11112	3 GHz ~ 10 GHz	Fig.31	Р
	10 GHz ~ 26 GHz	Fig.32	Р
	Center Frequency	Fig.33	Р
Ch 20	30 MHz ~ 1 GHz	Fig.34	Р
Ch 39 2441 MHz	1 GHz ~ 3 GHz	Fig.35	Р
	3 GHz ~ 10 GHz	Fig.36	Р
	10 GHz ~ 26 GHz	Fig.37	Р
	Center Frequency	Fig.38	Р
Ch 70	30 MHz ~ 1 GHz	Fig.39	Р
Ch 78 2480 MHz	1 GHz ~ 3 GHz	Fig.40	Р
	3 GHz ~ 10 GHz	Fig.41	Р
	10 GHz ~ 26 GHz	Fig.42	Р

For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
Ch 0 2402 MHz	Center Frequency	Fig.43	Р
	30 MHz ~ 1 GHz	Fig.44	Р
	1 GHz ~ 3 GHz	Fig.45	Р
	3 GHz ~ 10 GHz	Fig.46	Р
	10 GHz ~ 26 GHz	Fig.47	Р



01.00	Center Frequency	Fig.48	Р
	30 MHz ~ 1 GHz	Fig.49	Р
Ch 39 2441 MHz	1 GHz ~ 3 GHz	Fig.50	Р
2	3 GHz ~ 10 GHz	Fig.51	Р
	10 GHz ~ 26 GHz	Fig.52	Р
Ch 78 2480 MHz	Center Frequency	Fig.53	Р
	30 MHz ~ 1 GHz	Fig.54	Р
	1 GHz ~ 3 GHz	Fig.55	Р
	3 GHz ~ 10 GHz	Fig.56	Р
	10 GHz ~ 26 GHz	Fig.57	Р

Conclusion: PASS
Test graphs as below

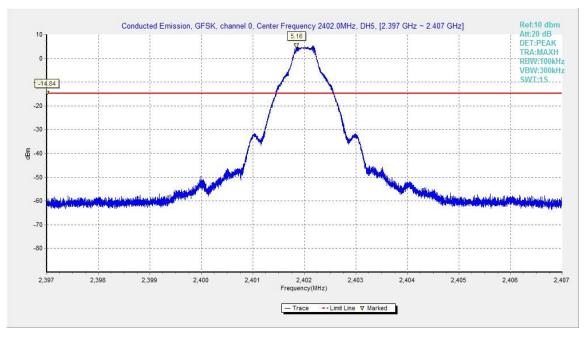


Fig.13. Conducted spurious emission: GFSK, Channel 0,2402MHz



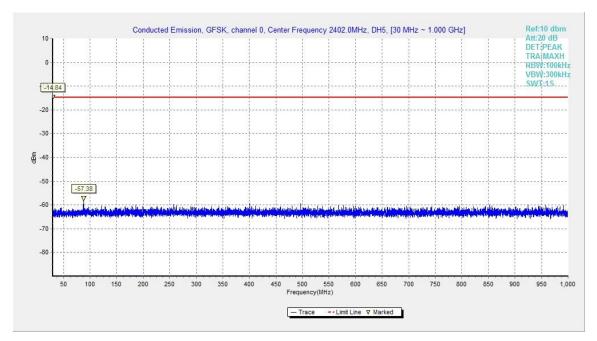


Fig.14. Conducted spurious emission: GFSK, Channel 0, 30MHz - 1GHz

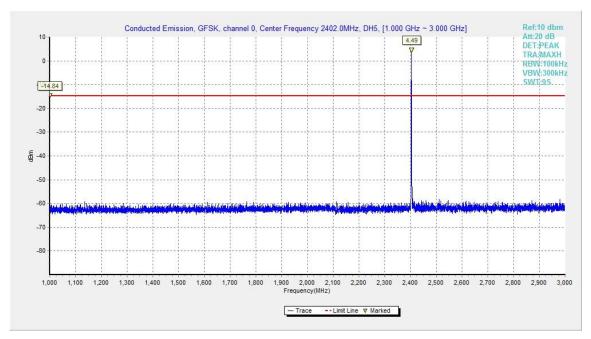


Fig.15. Conducted spurious emission: GFSK, Channel 0, 1GHz - 3GHz



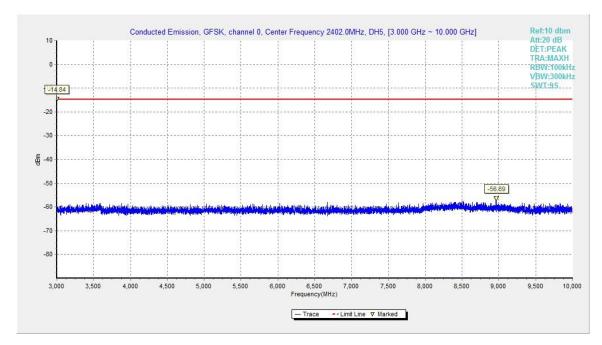


Fig.16. Conducted spurious emission: GFSK, Channel 0, 3GHz - 10GHz

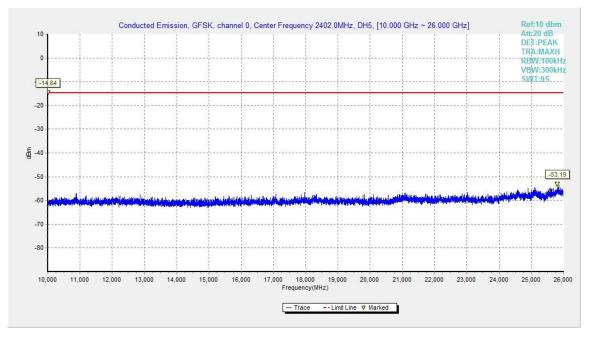


Fig.17. Conducted spurious emission: GFSK, Channel 0,10GHz - 26GHz



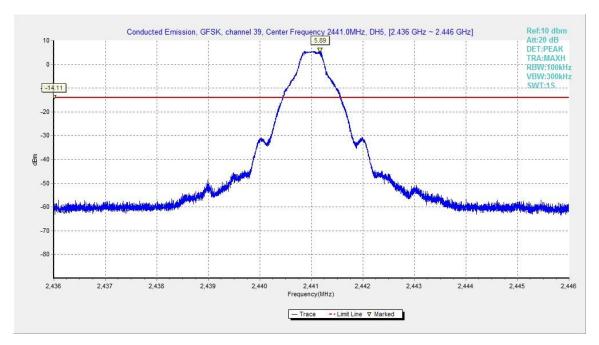


Fig.18. Conducted spurious emission: GFSK, Channel 39, 2441MHz

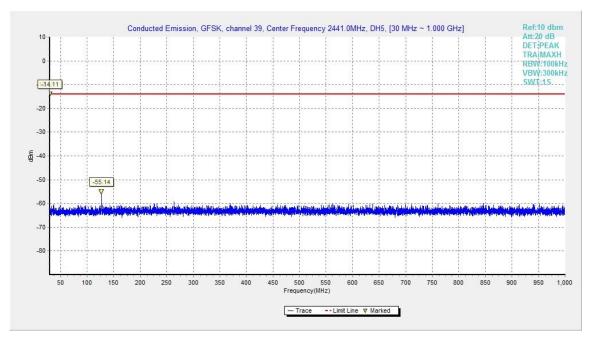


Fig.19. Conducted spurious emission: GFSK, Channel 39, 30MHz - 1GHz



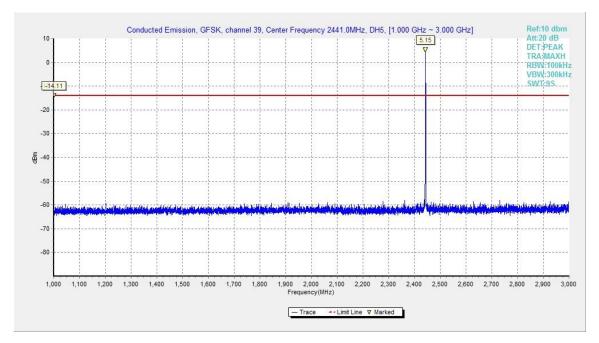


Fig.20. Conducted spurious emission: GFSK, Channel 39, 1GHz – 3GHz

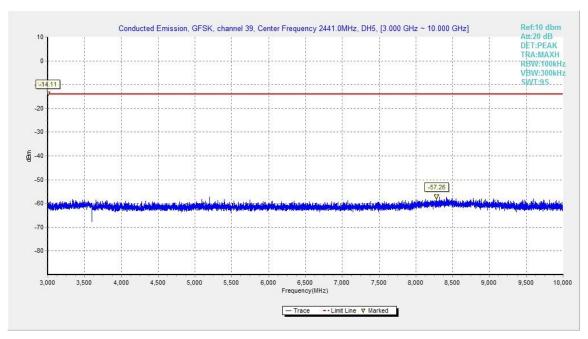


Fig.21. Conducted spurious emission: GFSK, Channel 39, 3GHz - 10GHz



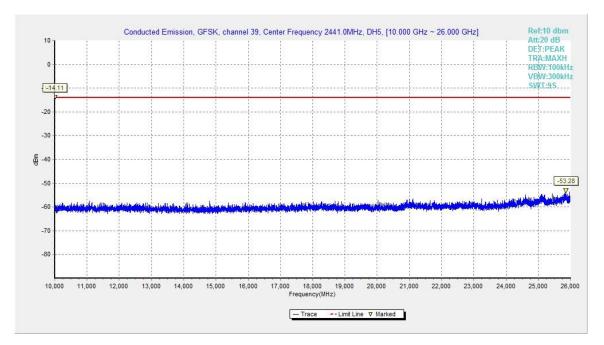


Fig.22. Conducted spurious emission: GFSK, Channel 39, 10GHz – 26GHz

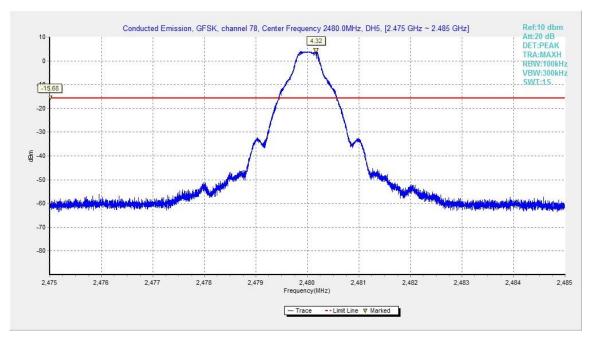


Fig.23. Conducted spurious emission: GFSK, Channel 78, 2480MHz



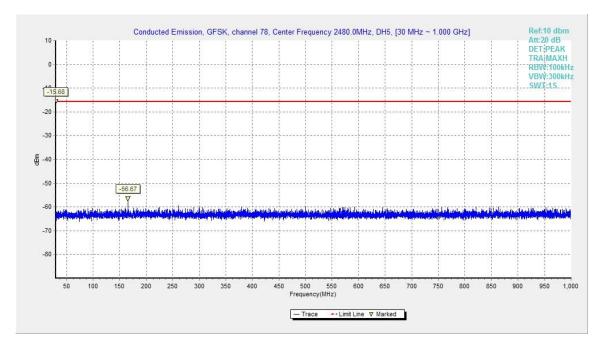


Fig.24. Conducted spurious emission: GFSK, Channel 78, 30MHz - 1GHz

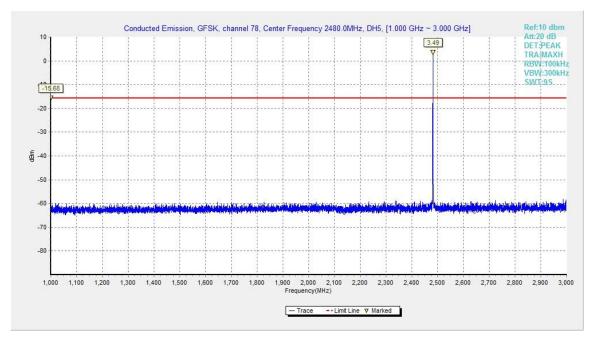


Fig.25. Conducted spurious emission: GFSK, Channel 78, 1GHz - 3GHz



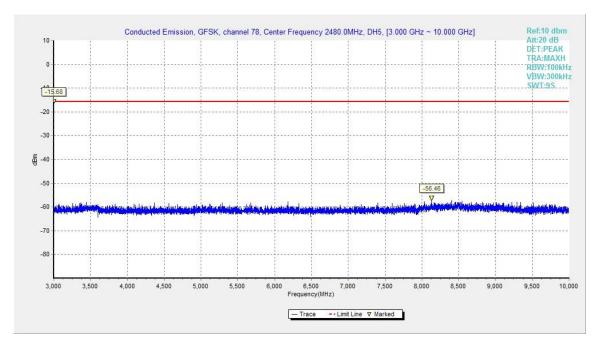


Fig.26. Conducted spurious emission: GFSK, Channel 78, 3GHz - 10GHz

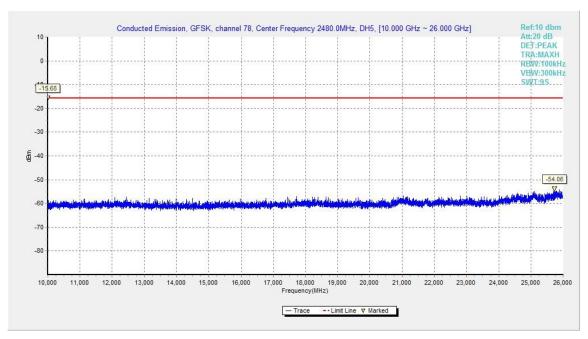


Fig.27. Conducted spurious emission: GFSK, Channel 78, 10GHz - 26GHz



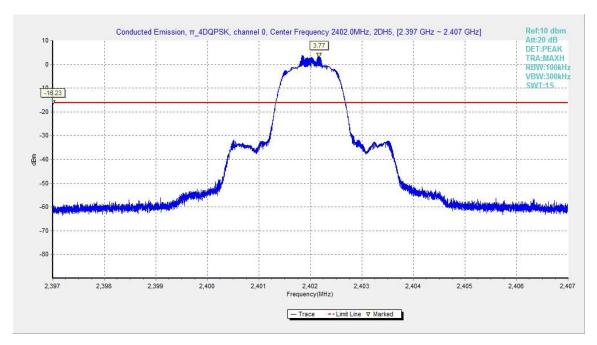


Fig.28. Conducted spurious emission: $\pi/4$ DQPSK, Channel 0,2402MHz

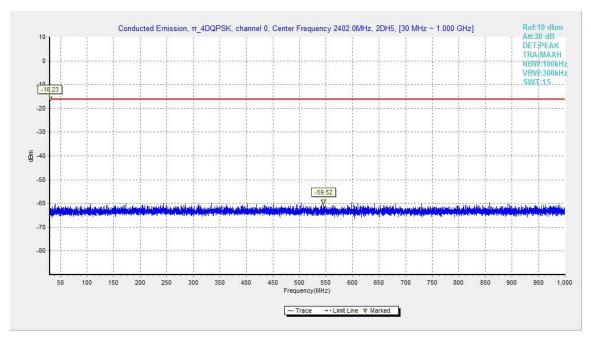


Fig.29. Conducted spurious emission: $\pi/4$ DQPSK, Channel 0, 30MHz - 1GHz



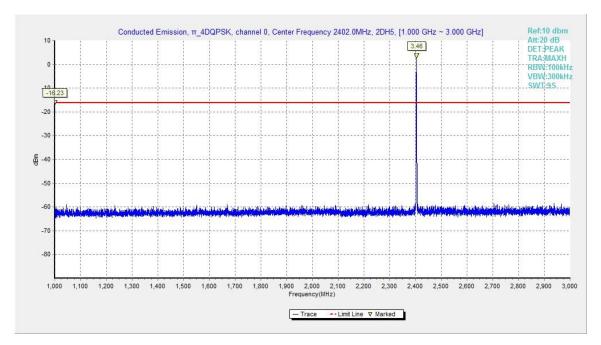


Fig.30. Conducted spurious emission: π/4 DQPSK, Channel 0, 1GHz - 3GHz

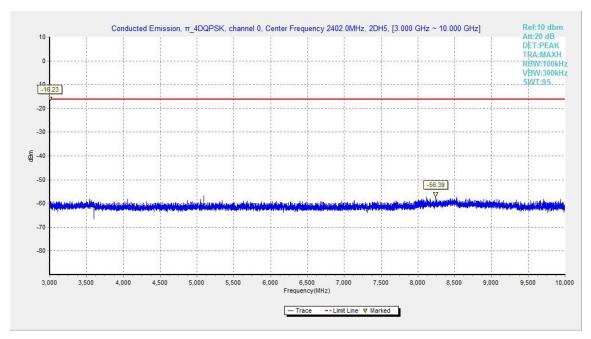


Fig.31. Conducted spurious emission: π/4 DQPSK, Channel 0, 3GHz - 10GHz



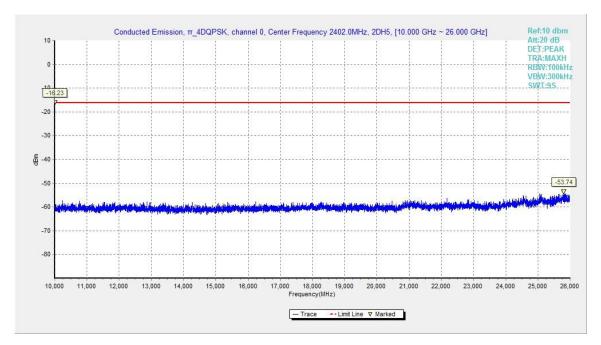


Fig.32. Conducted spurious emission: $\pi/4$ DQPSK, Channel 0,10GHz - 26GHz

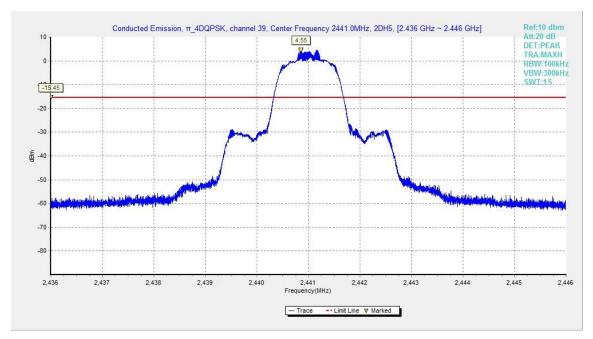


Fig.33. Conducted spurious emission: $\pi/4$ DQPSK, Channel 39, 2441MHz



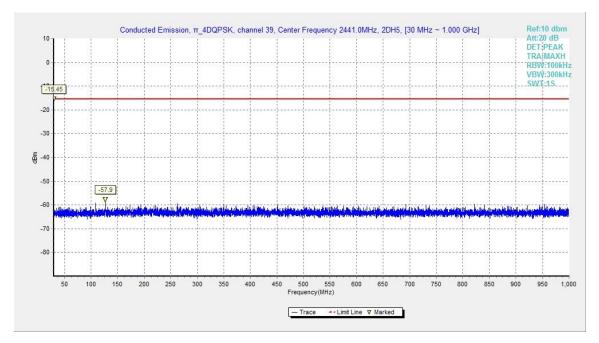


Fig.34. Conducted spurious emission: $\pi/4$ DQPSK, Channel 39, 30MHz - 1GHz

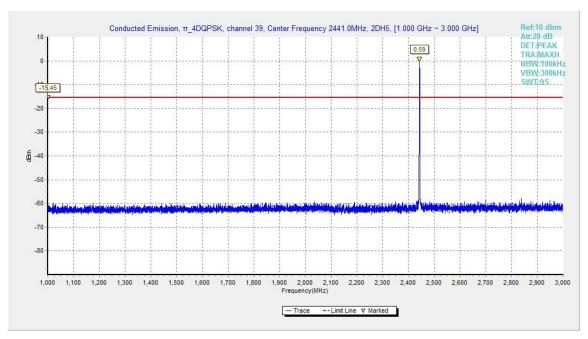


Fig.35. Conducted spurious emission: $\pi/4$ DQPSK, Channel 39, 1GHz - 3GHz



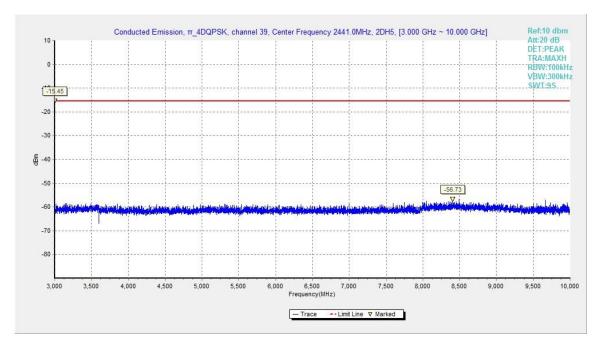


Fig.36. Conducted spurious emission: $\pi/4$ DQPSK, Channel 39, 3GHz - 10GHz

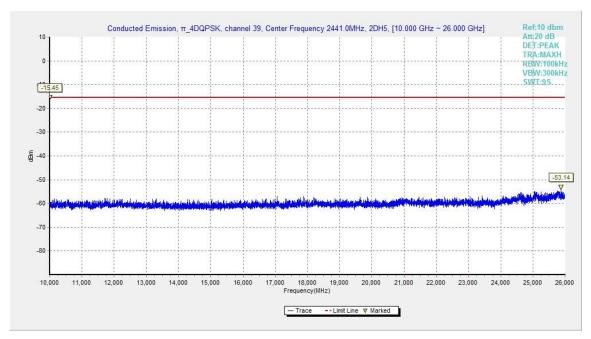


Fig.37. Conducted spurious emission: π/4 DQPSK, Channel 39, 10GHz – 26GHz



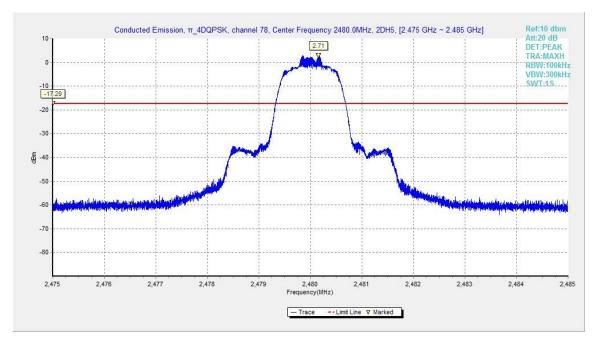


Fig.38. Conducted spurious emission: $\pi/4$ DQPSK, Channel 78, 2480MHz

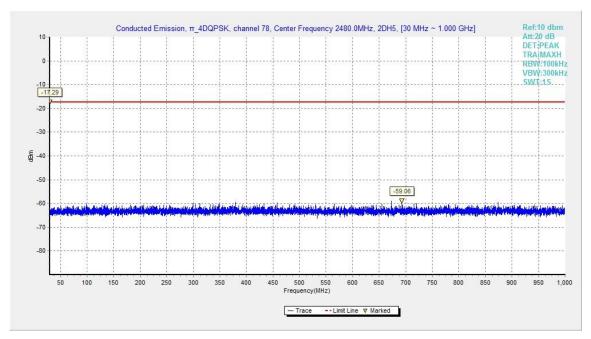


Fig.39. Conducted spurious emission: π/4 DQPSK, Channel 78, 30MHz - 1GHz



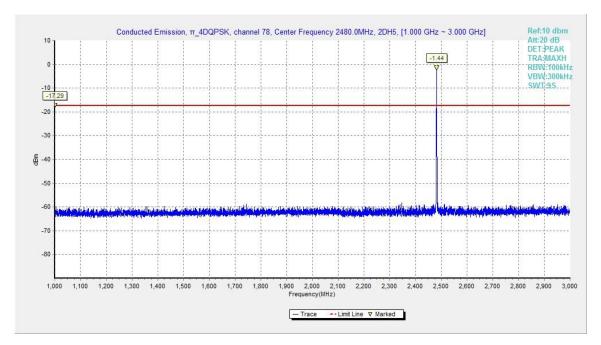


Fig.40. Conducted spurious emission: $\pi/4$ DQPSK, Channel 78, 1GHz - 3GHz

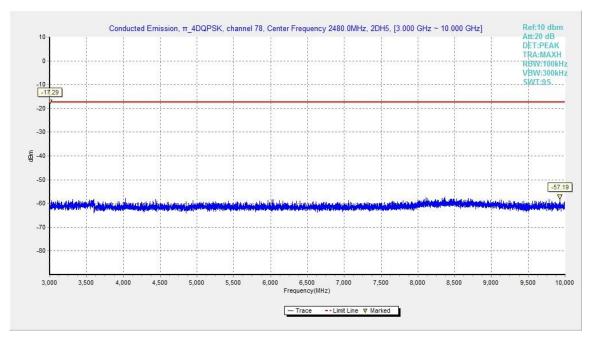


Fig.41. Conducted spurious emission: π/4 DQPSK, Channel 78, 3GHz - 10GHz



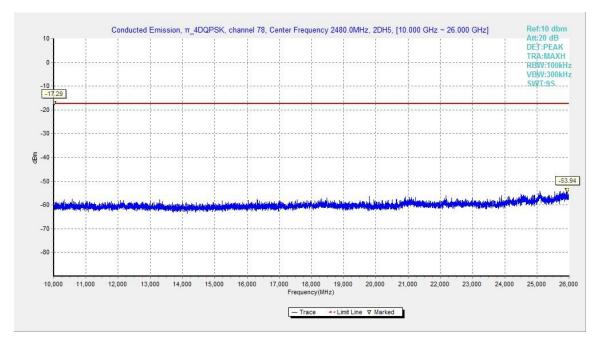


Fig.42. Conducted spurious emission: $\pi/4$ DQPSK, Channel 78, 10GHz - 26GHz

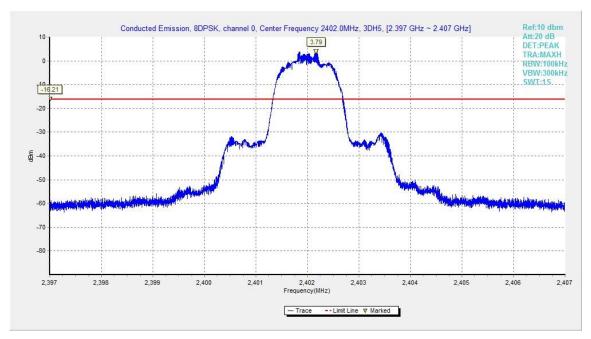


Fig.43. Conducted spurious emission: 8DPSK, Channel 0,2402MHz



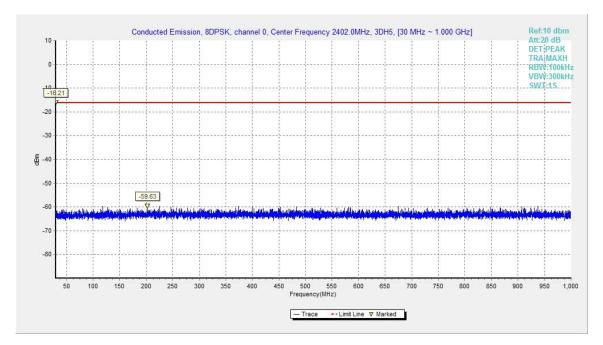


Fig.44. Conducted spurious emission: 8DPSK, Channel 0, 30MHz - 1GHz

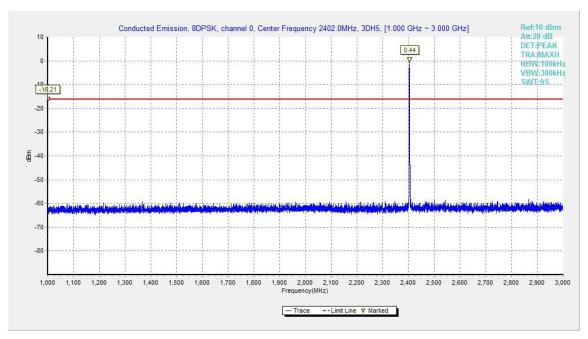


Fig.45. Conducted spurious emission: 8DPSK, Channel 0, 1GHz - 3GHz



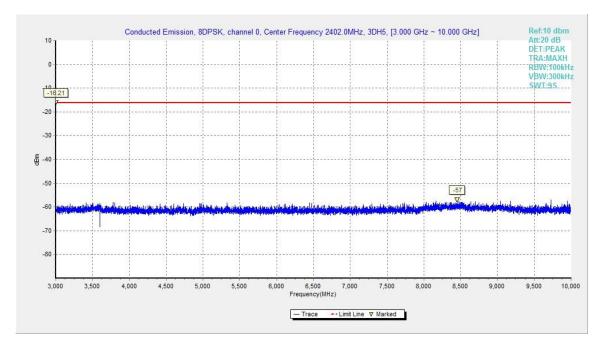


Fig.46. Conducted spurious emission: 8DPSK, Channel 0, 3GHz - 10GHz

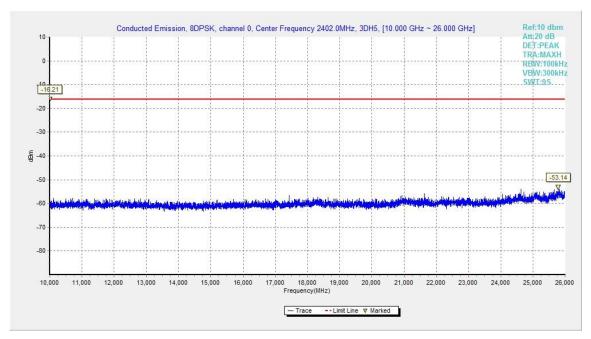


Fig.47. Conducted spurious emission: 8DPSK, Channel 0,10GHz - 26GHz



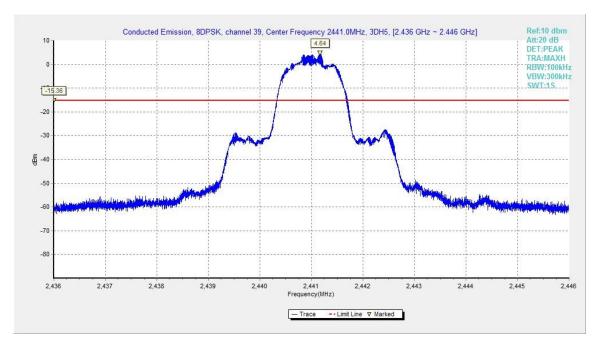


Fig.48. Conducted spurious emission: 8DPSK, Channel 39, 2441MHz

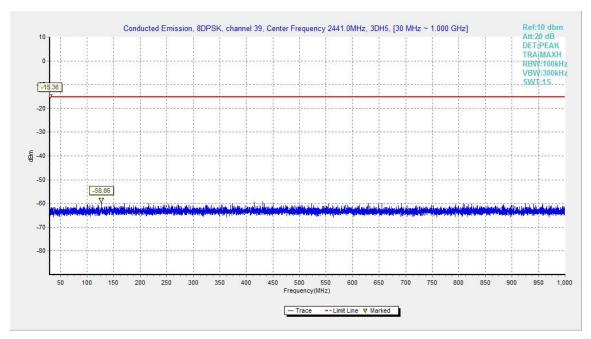


Fig.49. Conducted spurious emission: 8DPSK, Channel 39, 30MHz - 1GHz